



P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary (Typ. @ V_{GS} = -4.5V, T_A = +25°C)

V _{DSS}	R _{DS(on)}	Qg	Q_{gd}	I _D
-20V	28mΩ	5.4nC	1.5nC	-5.8A

Description and Applications

This new generation MOSFET is designed to minimize the onstate resistance (R_{DS(on)}) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Applications

- **Battery Management**
- Load Switch
- **Battery Protection**

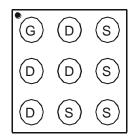
Features and Benefits

- LD-MOS Technology with the Lowest Figure of Merit: $R_{DS(on)} = 28m\Omega$ to Minimize On-State Losses Q_q = 5.4nC for Ultra-Fast Switching
- V_{gs(th)} = -0.6V typ. for a Low Turn-On Potential
- CSP with Footprint 1.5mm x 1.5mm
- Height = 0.62mm for Low Profile
- ESD = 3kV HBM Protection of Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

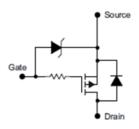
Mechanical Data

- Case: U-WLB1515-9
- Terminal Connections: See Diagram Below
- Weight: 0.0018 grams (Approximate)





Top-View Pin Configuration



Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMP2033UCB9-7	U-WLB1515-9	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.</p>
 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



AW = Product Type Marking Code YM = Date Code Marking Y = Year (ex: Y = 2011)M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016	2	017
Code	Y		Z		Α	E	3	С		D		Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Drain-Source Voltage		V _{DSS}	-20	V	
Gate-Source Voltage		V _{GSS}	-6	V	
Continuous Drain Current (Note 5) V _{GS} = -4.5V	Steady State	T _A = +25°C T _A = +70°C	I _D	-4.2A -3.3A	А
Continuous Drain Current (Note 6) V _{GS} = -4.5V	I _D	-5.8A -4.5A	А		
Pulsed Drain Current		I _{DM}	-30	Α	

Thermal Characteristics (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	P _D	1.0	W
Total Power Dissipation (Note 6)	P _D	1.8	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ heta JA}$	126.8	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{ heta JA}$	69	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)				l		
Drain-Source Breakdown Voltage	BV _{DSS}	-20	-	-	V	$V_{GS} = 0V, I_D = -250\mu A$
Gate-Source Breakdown Voltage	BV _{GSS}	-6.1	-	-	V	$I_{GS} = -250 \mu A, V_{DS} = 0 V$
Zero Gate Voltage Drain Current @Tc =	+25°C I _{DSS}	-	-	-1	μΑ	$V_{DS} = -16V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	-100	nA	$V_{GS} = -6V$, $V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	-0.4	-0.6	-1.1	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
			28	33		$V_{GS} = -4.5V, I_D = -2A$
Static Drain-Source On-Resistance	R _{DS} (ON)	-	35	45	mΩ	$V_{GS} = -2.5V, I_{D} = -2A$
			45	65		$V_{GS} = -1.8V, I_D = -2A$
Forward Transfer Admittance		-	10.8	-	S	$V_{DS} = -10V, I_{D} = -2A$
Diode Forward Voltage (Note 6)		-	-0.7	-1	V	$V_{GS} = 0V, I_{S} = -2A$
Reverse Recovery Charge		-	15	-	nC	$V_{dd} = -9.5V, I_F = -2A,$
Reverse Recovery Time	t _{rr}	1	25	-	ns	di/dt = 200A/µs
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	-	382	500	pF	10)/)/ 0)/
Output Capacitance		-	204	270	pF	$V_{DS} = -10V, V_{GS} = 0V,$ - f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	-	86	115	pF	1 - 1.000112
Series Gate Resistance	R_{G}		26.1	35	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (4.5V)	Qg	1	5.4	7.0	nC	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Gate-Source Charge	Q_{gs}	1	0.7	-	nC	$V_{GS} = -4.5V, V_{DS} = -10V,$ $I_{D} = -2A$
Gate-Drain Charge	Q_{gd}	1	1.5	-	nC	ID = -2A
Turn-On Delay Time	t _{D(on)}	-	8.5	-	ns	
Turn-On Rise Time	t _r	-	11.8	-	ns	$V_{DD} = -10V, V_{GS} = -4.5V,$
Turn-Off Delay Time	t _{D(off)}	-	47	-	ns	$I_{DS} = -2A$, $R_G = 2\Omega$,
Turn-Off Fall Time	t _f	-	56	-	ns	

Notes:

- 5. Device mounted on FR-4 PCB with minimum recommended pad layout.
- 6. Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.



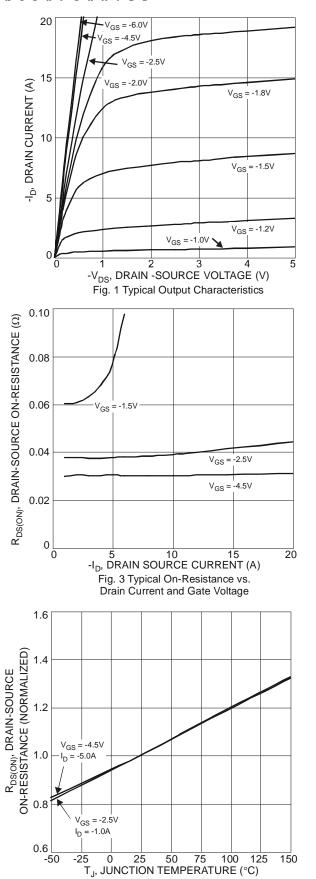
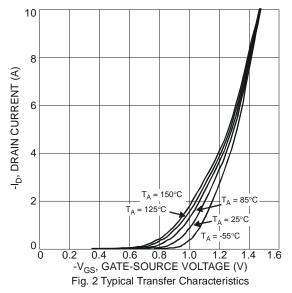
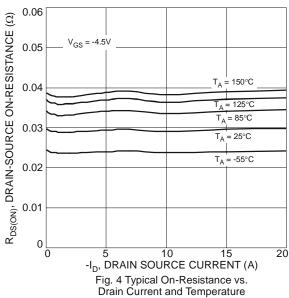
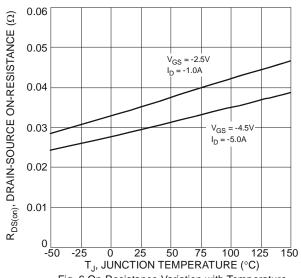


Fig. 5 On-Resistance Variation with Temperature









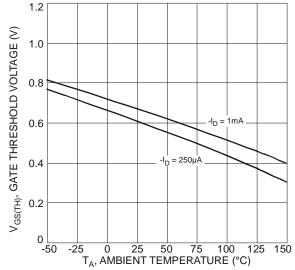
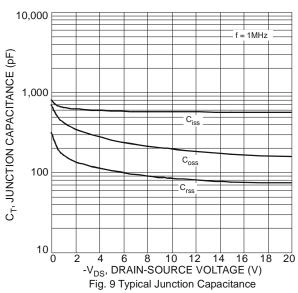
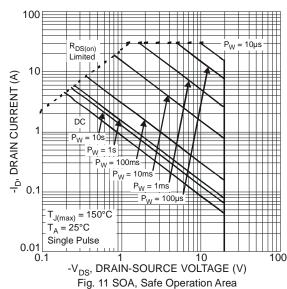
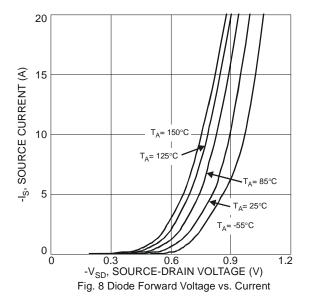
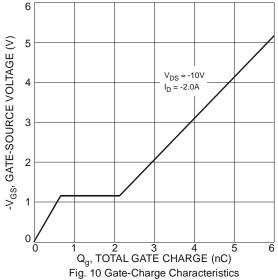


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

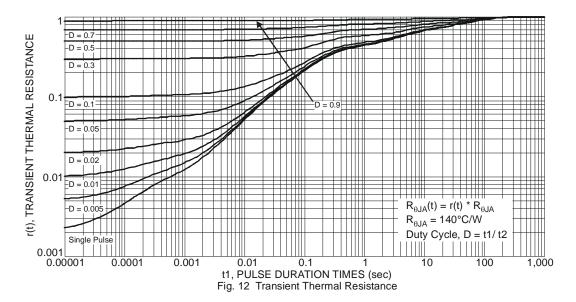






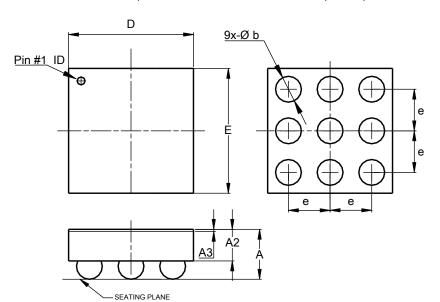






Package Outline Dimensions

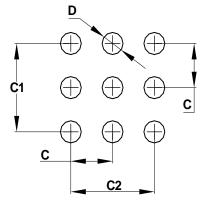
Please see AP02001 at http://www.diodes.com/_files/datasheets/ap02001.pdf for the latest version.



U-WLB1515-9						
Dim	Min	Max	Тур			
Α	-	0.62	-			
A2	-	0.36	0.36			
A3	0.020	0.030	0.025			
b	0.27	0.37	0.32			
D	1.47	1.51	1.49			
Е	1.47	1.51	1.49			
е	-	-	0.50			
All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/_files/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	0.50
C1	1.00
C2	1.00
D	0.25



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